Substitute Form PTO-1449

U.S. Department of Commerce Patent and Trademark Office

Attorney's Docket No. 5304/449001

Application No. 09/712,389

Information Disclosure Statement

by Applicant (Use several sheets if necessary)

Applicant
Hung Chih Chen, et al.

Filing Date

November 13, 2000

Group Art Unit 3723

			U.S. Pate	ent Documents		T	1 =
Examiner I <u>ni</u> tial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
PNQ.	AA	4,373,991/	02/83	Banks		l	
	AB	4,918,869/	04/90	Kitta			
	AC	5,081,795	01/92	Tanaka et al.			
	AD	5,193,316/	03/93	Olmstead			
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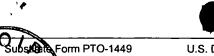
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Date Considered

9-26-2002

EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



(Modified)

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ANN	AWW	U.S. Patent Application Serial No. 09/470,820/				

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